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Applicant(s)/Patent under Reexamination

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Examiner

CARRICO ET AL.
Art Unit

David G. Cervetti

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	SEARCHED		
Class	Subclass	Date	Examiner
713	194	7/22/2005	DGC
713	. ALL	7/15/2005	DGC
380	ALL	7/15/2005	DGC
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INT	INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Springer/ACM/IEEE	7/15/2005	DGC
PLUS search requested	6/6/2005	DGC
Consulted w/ Syed Zia	7/21/2005	DGC
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